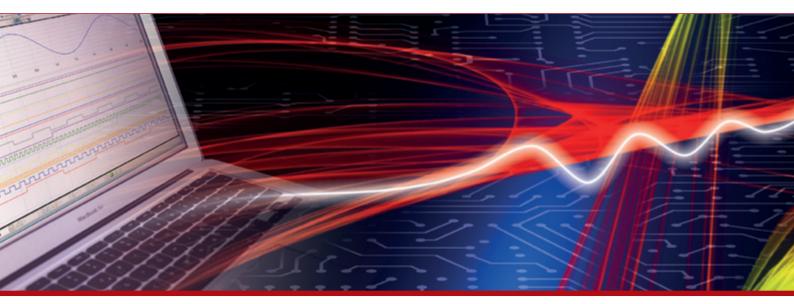


Product Datasheet - Technical Specifications



More information in our Web-Shop at ▶ www.meilhaus.com

Your contact

Technical and commercial sales, price information, quotations, demo/test equipment, consulting:

Tel.: +49 - (0)81 41 - 52 71-0

FAX: +49 - (0)81 41 - 52 71-129

E-Mail: sales@meilhaus.com



Designed for Simplicity and Reliability



Compatible LCR instruments

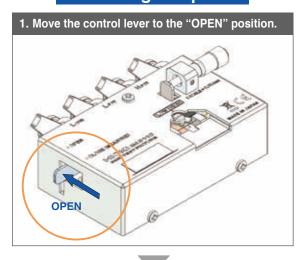
EIA unit: inch $(0.25 \text{ mm} \times 0.125 \text{ mm})$

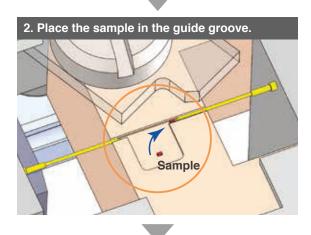


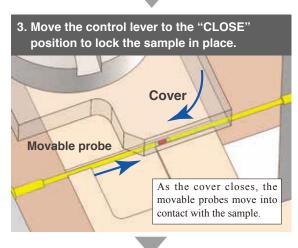
IM3590, IM3570, IM3536, IM3533, IM3523, 3511-50, 3506-10 3532-50 (legacy product), 3522-50 (legacy product)

Easily place samples via built-in cover that keeps the sample from popping out

Loading samples



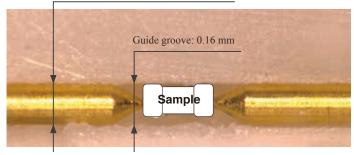






Probe contact

Measurement probe diameter: φ 0.155 mm



Shape of probe tip: 60° cone

Advanced contact technology delivers highly reproducible measurement results.

Specifications

=	
Operating temperature	0°C to 40°C (32°F to 104°F), 80% RH or less
and humidity	(no condensation)
Storage temperature	-10°C to 55°C (14°F to 131°F), 80% RH or less
and humidity	(no condensation)
Dimensions	Approx. 99 mm (3.9 in) W x 42 mm (1.65 in) H x 73 mm (2.87 in) D
	(Excluding control lever, lock lever, and micrometer)
Mass	Approx. 270 g (9.5 oz)
Product warranty	3 year
Connection with sample	2-terminal connection from opposite sides
Measurable sample	$0.25 \pm 20\% \times 0.125 \pm 10\% \times 0.125 \pm 10\%$ mm
dimensions	(EIA size category: 008004)
	Please contact Hioki for information about other sizes.
Maximum applied voltage	±42 V peak (AC+DC)
Maximum applied current	0.15 Arms (±0.15 A DC)
Usable frequency range	DC to 1 MHz
Residual parameter	•Capacitance: C < 35 fF
values	(With 0.25 mm between measurement probes)
(Reference values with a	•Inductance: L < 120 nH
measurement frequency	(2-terminal contact while using short compensation fixture)
of 1 MHz)	•Resistance: $R < 800 \text{ m}\Omega$
	(2-terminal contact while using short compensation fixture)
Contact pressure on sample	0.14 N (15 gf) or less
Measurement probe	Set using a micrometer with a 0.01 mm graduated scale.
distance setting	(Inclusion of a micrometer allows the distance between measurement
ŭ	probes to be set easily. In particular, open compensation can be
	performed without a measurement sample.)
Connection to instrument	4-terminal pair
	(Connector: BNC; distance between connectors: 22 mm)
Accessories	User manual, short compensation fixture × 5, cleaning brush

Product Name: SMD TEST FIXTURE IM9110

Model No. (Order Code)	
IM9110	

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